



Bharati Vidyapeeth
New Delhi

IEEE Delhi Section with Computer Society Chapter, Consultants Network Affinity Group, Life Member Affinity Group, Inter Society Relations, Industry Relations & SIGHT Standing Committees of IEEE Delhi Section
With following associations



Computer Society of India



Safa Society,
New Delhi



ISTE Delhi Section



IETE Delhi Centre



IEEE COMPUTER SOCIETY
Computer Society Chapter
IEEE Delhi Section

Invite you for a Free **Webinar** on **02-July-2020, the Thursday**, at **05:00 p.m.**
as per the details given hereunder:-

Speaker

Ms. R. Ezhirpavai,
Vice President – Innovation, Altran

Date and Time Schedule

02-July-2020, the Thursday, from 05:00 p.m. to 06:30 p.m.

Title of the Talk

5G – Myth busters and benefits for Indian environment

Venue and Contact Details

CISCO WebEx Meeting Platform
Dr. Vishal Jain (+91 9899997263; E-Mail ID: vishal.jain@bvicam.in)
CISCO WebEx Event ID and Password shall be sent on E-Mail to the registered participants

Program Schedule

04:30 p.m. to 05:00 p.m. – Login, online Networking and Tea (at Home)
05:00 p.m. to 06:00 p.m. – Technical Talk
06:00 p.m. to 06:30 p.m. – Q & A Session followed by Certification

Registration Link and Fee

Registration Link: <http://bvicam.ac.in/webinars/>
No registration fee. It is absolutely free for the members of IEEE, CSI, IETE, ISTE, ISCA and Bharati Vidyapeeth, with pre-registration

Preview of the Talk

1. What is a typical 5G architecture?
2. Some key terms explained like CUPS, MEC/Edge, Cloud, Service based interface.
3. Some use cases typically advantages with 5G.
4. Myths about 5G and the fact against the same.

All are welcome:

Please circulate this to all your interested colleagues, associates and friends. Please register in large numbers and derive maximum benefit. **Advance registration is mandatory for participation. Participants will also get Participation Certificate.**

(Prof. M. N. Hoda)
Director, BVICAM

(Mr. Ajay Goel)
Vice President, Altran

(Prof. Subrata Mukhopadhyay)
Chairperson, CNA Group, IEEE DS